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Insulated Gate Bipolar Transistor (Trench IGBT), 650 V, 120 A



PRIMARY CHARACTERISTICS						
V _{CES}	650 V					
I _C DC	120 A at 90 °C					
V _{CE(on)} typical at 100 A, 25 °C	1.71 V					
I _F DC	76 A at 90 °C					
Speed	8 kHz to 30 kHz					
Package	SOT-227					
Circuit configuration	Single switch with AP diode					

FEATURES

 Trench IGBT technology with positive temperature coefficient



- Square RBSOA
- FRED Pt[®] antiparallel diodes with ultrasoft reverse recovery
- Fully isolated package
- Very low internal inductance (≤ 5 nH typical)
- Industry standard outline
- UL pending
- Material categorization: for definitions of compliance please see <u>www.vishav.com/doc?99912</u>

BENEFITS

- Designed for increased operating efficiency in power conversion: UPS, SMPS, welding, induction heating
- Easy to assemble and parallel
- · Direct mounting to heatsink
- Plug-in compatible with other SOT-227 packages
- Lower conduction losses and switching losses
- · Low EMI, requires less snubbing

ABSOLUTE MAXIMUM RATINGS					
PARAMETER	SYMBOL	TEST CONDITIONS	MAX.	UNITS	
Collector to emitter voltage	V _{CES}		650	V	
Continuous collector current	1-	T _C = 25 °C	167		
Continuous collector current	Ic	T _C = 90 °C	120		
Pulsed collector current	I _{CM}		220	Α	
Clamped inductive load current	I _{LM}		220	A	
Diode continuous forward current		T _C = 25 °C	110		
	IF	T _C = 90 °C	76		
Single pulse forward current	I _{FSM}	10 ms sine or 6 ms rectangular pulse, T _J = 25 °C	550	Α	
Gate-to-emitter voltage	V_{GE}		± 20	V	
Dower discipation ICDT	Б	T _C = 25 °C	577		
Power dissipation, IGBT	P _D	T _C = 90 °C	327	w	
Power dissipation, diode	Б	T _C = 25 °C	238	VV	
	P _D	T _C = 90 °C	135		
Isolation voltage	V _{ISOL}	Any terminal to case, t = 1 min	2500	V	



ELECTRICAL SPECIFICATIONS (T _J = 25 °C unless otherwise specified)							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS	
Collector to emitter breakdown voltage	V _{BR(CES)}	$V_{GE} = 0 \text{ V}, I_{C} = 100 \mu\text{A}$	650	-	-		
		$V_{GE} = 15 \text{ V}, I_{C} = 100 \text{ A}$	-	1.71	2.00		
Collector to emitter voltage	V _{CE(on)}	V_{GE} = 15 V, I_{C} = 100 A, T_{J} = 125 °C	-	2.00	-	V	
		$V_{GE} = 15 \text{ V}, I_{C} = 100 \text{ A}, T_{J} = 175 ^{\circ}\text{C}$	-	2.17	-		
Gate threshold voltage	V _{GE(th)}	$V_{CE} = V_{GE}$, $I_C = 3.3 \text{ mA}$	5.1	6.1	8.3		
Temperature coefficient of threshold voltage	$\Delta V_{GE(th)}/\Delta T_{J}$	$V_{CE} = V_{GE}$, $I_{C} = 1$ mA (25 °C to 125 °C)	-	-20	-	mV/°C	
		$V_{GE} = 0 \text{ V}, V_{CE} = 650 \text{ V}$	-	1.2	50		
Collector to emitter leakage current	I _{CES}	$V_{GE} = 0 \text{ V}, V_{CE} = 650 \text{ V}, T_{J} = 125 ^{\circ}\text{C}$	-	80	-	μΑ	
		$V_{GE} = 0 \text{ V}, V_{CE} = 650 \text{ V}, T_{J} = 175 ^{\circ}\text{C}$	-	2.0	-	mA	
		$I_C = 100 \text{ A}, V_{GE} = 0 \text{ V}$	-	2.00	2.53		
Forward voltage drop, diode	V_{FM}	$I_C = 100 \text{ A}, V_{GE} = 0 \text{ V}, T_J = 125 ^{\circ}\text{C}$	-	1.69	-	V	
		$I_C = 100 \text{ A}, V_{GE} = 0 \text{ V}, T_J = 175 °C$	_	1.55	-		
Gate to emitter leakage current	I _{GES}	$V_{GE} = \pm 20 \text{ V}$	-	-	± 660	nA	

SWITCHING CHARACTERISTICS (T _J = 25 °C unless otherwise specified)							
PARAMETER	SYMBOL	TEST CONDIT	IONS	MIN.	TYP.	MAX.	UNITS
Input capacitance	C _{iss}			-	6600	-	
Output capacitance	C _{oss}	$V_{GE} = 0 \text{ V}, V_{CE} = 30 \text{ V}, f =$	= 1.0 MHz	-	340	-	рF
Reverse transfer capacitance	C _{rss}			-	180	-	
Total gate charge (turn-on)	Q_g			-	190	-	
Gate to emitter charge (turn-on)	Q _{ge}	$I_C = 100 \text{ A}, V_{CC} = 400 \text{ V},$	V _{GE} = 15 V	-	65	-	nC
Gate to collector charge (turn-on)	Q _{gc}			-	80	=	
Turn-on switching loss	E _{on}			-	0.32	-	
Turn-off switching loss	E _{off}			-	1.5	-	mJ
Total switching loss	E _{tot}	$I_C = 100 \text{ A}, V_{CC} = 325 \text{ V},$		-	1.82	-	
Turn-on delay time	t _{d(on)}	$V_{GE} = 15 \text{ V}, R_{q} = 4.7 \Omega,$		-	114	-	- ns
Rise time	t _r	L = 500 μH		-	73	-	
Turn-off delay time	t _{d(off)}		Energy losses include tail and diode recovery.	-	107	-	
Fall time	t _f			-	68	-	
Turn-on switching loss	E _{on}			-	0.52	-	mJ
Turn-off switching loss	E _{off}			-	1.85	-	
Total switching loss	E _{tot}	$I_C = 100 \text{ A}, V_{CC} = 325 \text{ V},$		-	2.37	-	
Turn-on delay time	t _{d(on)}	$V_{GE} = 15 \text{ V}, R_{g} = 4.7 \Omega,$		-	115	-	ns ns
Rise time	t _r	$L = 500 \mu H, T_J = 125 \degree C$		-	74	-	
Turn-off delay time	t _{d(off)}			-	114	-	
Fall time	t _f			-	89	-	
Reverse bias safe operating area	RBSOA	T_J = 175 °C, I_C = 220 A, R_g = 10 Ω , V_{GE} = 15 V to 0 V, V_{CC} = 325 V, V_P = 650 V, L = 500 μ H		Fullsquare			
Short circuit safe operating area	SCSOA	V_{GE} = 15 V, V_{CC} = 400 V, R_g = 4.7 Ω , $V_P \le$ 650 V, T_J = 150 °C		-	-	5.5	μs
Diode reverse recovery time	t _{rr}	$I_F = 50 \text{ A}, dI_F/dt = 200 \text{ A/}\mu\text{s}, V_R = 200 \text{ V}$		-	72	-	ns
Diode peak reverse current	I _{rr}			-	5.3	-	Α
Diode recovery charge	Q _{rr}			-	192	-	nC
Diode reverse recovery time	t _{rr}	I _F = 50 A, dI _F /dt = 200 A/μs, V _B = 200 V, T _J = 125 °C		-	149	-	ns
Diode peak reverse current	I _{rr}			-	13	-	Α
Diode recovery charge	Q _{rr}	TH = 200 V, IJ = 120 O		-	974	-	nC



THERMAL AND MECHANICAL SPECIFICATIONS							
PARAMETER		SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Junction and storage temper	erature range	T _J , T _{Stg}		-40	-	175	°C
Junction to case		D		-	-	0.26	
Junction to case	Diode	R _{thJC}		-	-	0.63	°C/W
Case to heatsink		R _{thCS}	Flat, greased surface	-	0.1	-	
Weight				-	30	-	g
Mounting toward			Torque to terminal	-	-	1.1 (9.7)	Nm (lbf.in)
Mounting torque			Torque to heatsink	-	-	1.8 (15.9)	Nm (lbf.in)
Case style			S	OT-227			

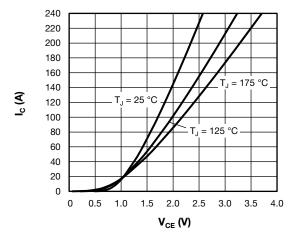


Fig. 1 - Typical IGBT Output Characteristics, $V_{\text{GE}} = 15 \text{ V}$

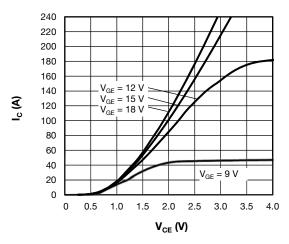


Fig. 2 - Typical IGBT Output Characteristics, T_J = 125 °C

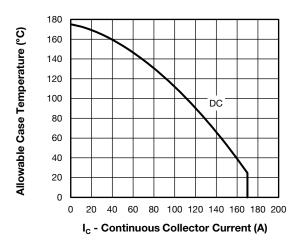


Fig. 3 - Maximum IGBT Continuous Collector Current vs. Case Temperature

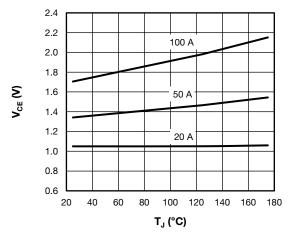


Fig. 4 - Collector to Emitter Voltage vs. Junction Temperature



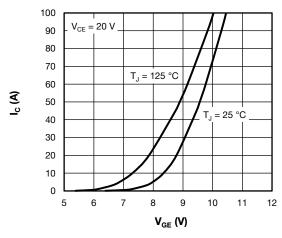


Fig. 5 - Typical IGBT Transfer Characteristics

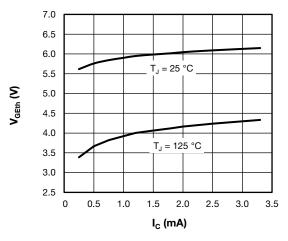


Fig. 6 - Typical IGBT Gate Threshold Voltage

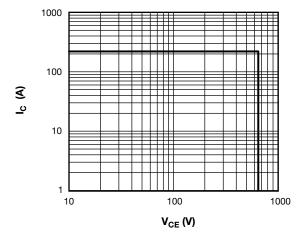


Fig. 7 - IGBT Reverse BIAS SOA T_J = 175 °C, V_{GE} = 15 V

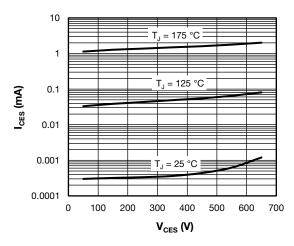


Fig. 8 - Typical IGBT Zero Gate Voltage Collector Current

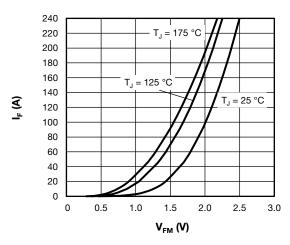


Fig. 9 - Typical Diode Forward Characteristics

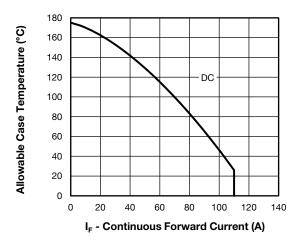


Fig. 10 - Maximum Diode Continuous Forward Current vs. Case Temperature



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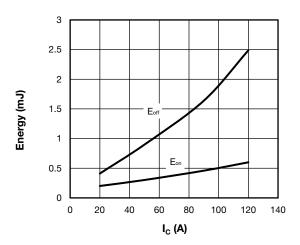


Fig. 11 - Typical IGBT Energy Loss vs. I_C T_J = 125 °C, V_{CC} = 325 V, R_g = 4.7 $\Omega,$ V_{GE} = 15 V, L = 500 μH

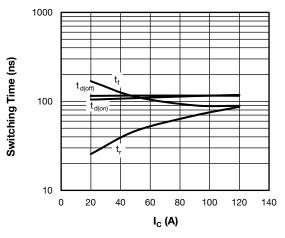


Fig. 12 - Typical IGBT Switching Time vs. I_C T $_J$ = 125 °C, V $_{CC}$ = 325 V, R $_g$ = 4.7 $\Omega,$ V $_{GE}$ = 15 V, L = 500 μH

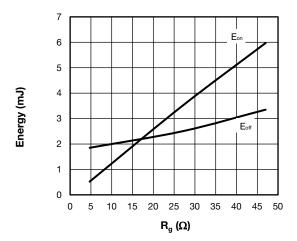


Fig. 13 - Typical IGBT Energy Loss vs. R_g T_J = 125 °C, V_{CC} = 325 V, I_C = 100 A, V_{GE} = 15 V, L = 500 μH

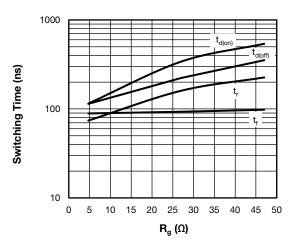


Fig. 14 - Typical IGBT Switching Time vs. R_g T_J = 125 °C, V_{CC} = 600 V, I_C = 100 A, V_{GE} = 15 V, L = 500 μH

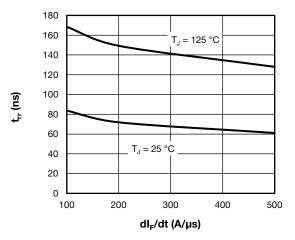


Fig. 15 - Typical t_{rr} Diode vs. dI_F/dt $V_{rr} = 200$ V, $I_F = 50$ A

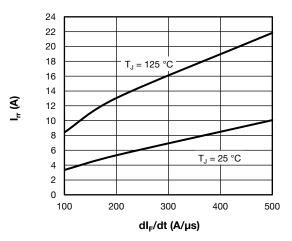


Fig. 16 - Typical I_{rr} Diode vs. dI_F/dt $V_{rr} = 200 \text{ V}$, $I_F = 50 \text{ A}$

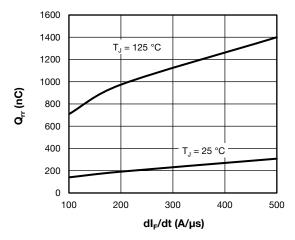


Fig. 17 - Typical Diode Reverse Recovery Charge vs. dI_F/dt $V_{rr} = 200 \text{ V}, I_F = 50 \text{ A}$

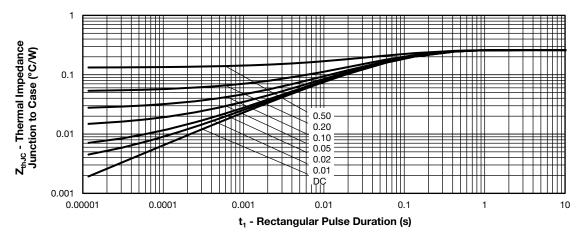


Fig. 18 - Maximum Thermal Impedance Z_{thJC} Characteristics, IGBT

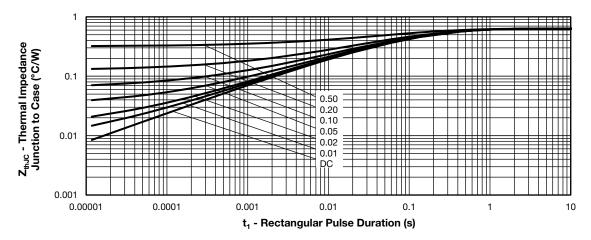
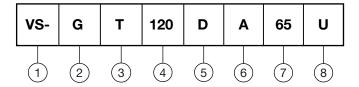


Fig. 19 - Maximum Thermal Impedance ZthJC Characteristics, Diode



ORDERING INFORMATION TABLE

Device code



- Vishay Semiconductors product
- Insulated gate bipolar transistor (IGBT)
- **3** T = trench IGBT
- Current rating (120 = 120 A)
- **5** Circuit configuration (D = single switch with antiparallel diode)
- 6 Package indicator (A = SOT-227)
- 7 Voltage rating (65 = 650 V)
- Speed/type (U = ultrafast IGBT)

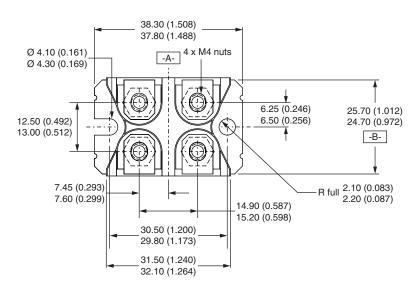
CIRCUIT CONFIGURATION					
CIRCUIT	CIRCUIT CONFIGURATION CODE	CIRCUIT DRAWING			
Single switch with AP diode	D	2 (G) O 1, 4 (E) Lead Assignment 1 2 (G) O			

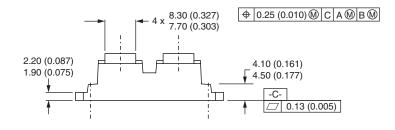
LINKS TO RELATED DOCUMENTS				
Dimensions	www.vishay.com/doc?95423			
Packaging information	www.vishay.com/doc?95425			

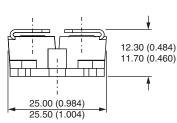


SOT-227 Generation II

DIMENSIONS in millimeters (inches)







Note

· Controlling dimension: millimeter



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